


<b>Search Notes</b>  	<b>Application/Control No.</b>  10615702	<b>Applicant(s)/Patent Under Reexamination</b>  MOCK, WAYNE E.
	<b>Examiner</b>  GELEK TOPGYAL	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	1,46,94,125,126	3/3/2008	GT
725	87	3/3/2008	GT

SEARCH NOTES		
Search Notes	Date	Examiner
Thai Tran: Gave search class. Initially suggested transferring, however transfer was not accepted by any other art unit.	3/3/2008	GT
Researched. Added new Watkins reference for 2nd Non Final.	10/21/2008	GT
Maintained Rejection.	4/10/2009	GT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/GELEK TOPGYAL/ Examiner.Art Unit 2621	
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